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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10509461 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>VAN DEN OETELAAR ET AL. |
|  | <b>Examiner</b><br><br>Heyi, Henok G           | <b>Art Unit</b><br><br>2609   |

| SEARCHED |          |      |          |
|----------|----------|------|----------|
| Class    | Subclass | Date | Examiner |
|          |          |      |          |

| SEARCH NOTES   |            |            |
|--|------------|------------|
| Search Notes   | Date       | Examiner   |
| East text searches have been done. 369/94, 275.1 (text search only - see search report printout). I have also relied on the international search report. | 06/05/2007 | Henok Heyi |
| Search Updated.  | 07/17/2008 | Henok Heyi |
| Search updated again.  | 10/02/2008 | Henok Heyi |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |

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